

Ultra-Compact, 1.5 A Thermoelectric Cooler (TEC) Controller

GENERAL DESCRIPTION

The SLM8833 is a monolithic TEC controller with an integrated TEC controller. It has a linear power stage and a pulse-width modulation (PWM) power stage.

The linear controller works with the PWM driver to control the internal power MOSFETs in an H-bridge configuration. Depending on the control voltage at the CONT input, the SLM8833 drives current through a TEC to settle the temperature of a laser diode or a passive component attached to the TEC module to the programmed target temperature.

The control voltage applied to the CONT input pin is generated by a digital-to-analog converter (DAC) closing the digital proportional, integral, derivative (PID) loop of temperature control system.

The internal 2.50 V reference voltage provides a 1% accurate output that is used to bias a thermistor temperature sensing bridge as well as a voltage divider network to program the maximum TEC current and voltage limits for both the heating and cooling modes. It can also be a reference voltage for the DAC and the temperature sensing circuit, including a thermistor bridge and an analog-to-digital converter (ADC).

FEATURES

- Integrated super low $R_{DS(on)}$ MOSFETs for the TEC controller
- High efficiency single inductor architecture
- TEC voltage and current operation monitoring
- No external sense resistor required
- Independent TEC heating and cooling current limit settings
- Programmable maximum TEC voltage
- 2.0 MHz PWM driver switching frequency
- External synchronization
- 2.50 V reference output with 1% accuracy
- Digital thermal control loop compatible
- Available in a 25-ball, 2.5 mm × 2.5 mm WLCSP or in a 24-lead, 4 mm × 4 mm QFN

APPLICATIONS

- TEC temperature control
- Optical modules
- Optical fiber amplifiers
- Optical networking systems
- Instruments requiring TEC temperature control

SYSTEM BLOCK DIAGRAM

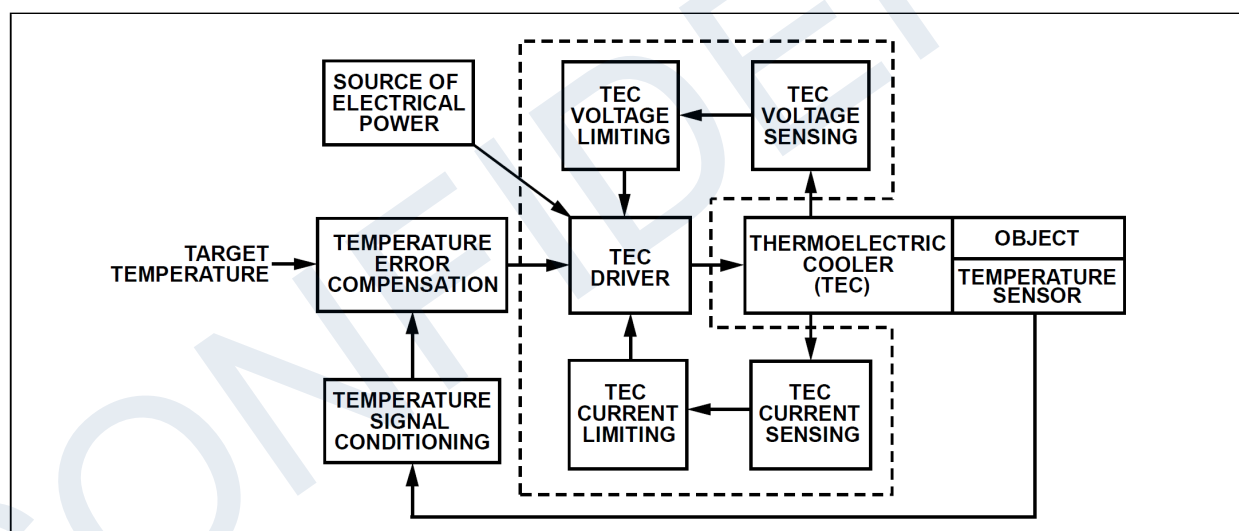


Figure 1. TEC System Block Diagram

Figure 2. Typical Application Circuit with Digital PID Compensation in a Temperature Control Loop

Figure 3. TEC Controller in a Digital Temperature Control Loop (WLCSP)

PIN CONFIGURATION

Package	25-ball, 2.5 mm × 2.5 mm WLCSP	24-lead, 4 mm × 4 mm QFN
Pin Configuration (Top View)	SLM8833 TOP VIEW (Not to Scale) 1 2 3 4 5 A (PGNDL) (PGNDL) (DNC) (DNC) (DNC) B (LDR) (LDR) (DNC) (DNC) (VLIM/SD) C (PVIN) (PVIN) (ITEC) (CONT) (ILIM) D (SW) (SW) (VTEC) (EN/SY) (VDD) E (PGND) (PGND) (SFB) (AGND) (VREF) 2.54mm 0.5mm PITCH	24 DNC 23 DNC 22 DNC 21 DNC 20 DNC 19 PGNDL DNC 1 18 PGNDL CONT 2 17 LDR VLIM/SD 3 16 PVINL ILIM 4 15 PVINS VDD 5 14 SW VREF 6 13 PGND AGND 7 12 PGND EN/SY 8 11 PGND VTEC 9 10 PGND SFB 10 9 PGND ITEC 11 8 PGND PGND 12 7 PGND SLM8833 TOP VIEW (Not to Scale)

PIN DESCRIPTION

Pin No.		Pin Name	Description
WLCSP	QFN		
A1, A2	18, 19	PGNDL	Power Ground of the Linear TEC Controller.
A3 to A5, B3, B4	1, 20 to 24	DNC	Do Not Connect. Don't connect to pins.
B1, B2	17	LDR	Output of the Linear TEC Controller.
B5	3	VLIM/SD	Voltage Limit/Shutdown. This pin sets the cooling and heating TEC voltage limits. When this pin is pulled low, the device shuts down.
C1, C2	N/A ¹	PVIN	Power Input for the TEC Controller.
N/A ¹	16	PVINL	Power Input for the Linear TEC Driver.
N/A ¹	15	PVINS	Power Input for the PWM TEC Driver.
C3	11	ITEC	TEC Current Output.
C4	2	CONT	Control Input of the TEC Driver. Apply a control signal from the DAC to this pin to close the thermal loop.
C5	4	ILIM	Current Limit. This pin sets the TEC cooling and heating current limits.
D1, D2	14	SW	Switch Node Output of the PWM TEC Controller.
D3	9	VTEC	TEC Voltage Output.
D4	8	EN/SY	Enable/Synchronization. Set this pin high to enable the device. An external synchronization clock input can be applied to this pin.
D5	5	VDD	Power for the Controller Circuits.
E1, E2	12, 13	PGNDS	Power Ground of the PWM TEC Controller.
E3	10	SFB	Feedback of the PWM TEC Controller Output.
E4	7	AGND	Signal Ground.
E5	6	VREF	2.5 V Reference Output.
N/A ¹	0	EPAD	Exposed Pad. Solder to the analog ground plane on the board.

N/A¹: Not Available.**ORDERING INFORMATION**

Industrial Range: -40°C to +125°C

Order Part No.	Package	QTY
SLM8833FA-7G	25-ball, 2.5 mm × 2.5 mm	500/Reel
SLM8833EC	WLCSP 24-lead, 4 mm × 4 mm QFN	1000/Reel

ABSOLUTE MAXIMUM RATINGS

PVIN to PGNDL / PGNDS (WLCSP)			-0.3 V ~ 6.0 V
PVINL to PGNDL; PBINS to PGNDS (QFN)			-0.3 V ~ 6.0 V
LDR to PGNDL (WLCSP)			-0.3 V ~ V _{PVIN}
LDR to PGNDL (QFN)			-0.3 V ~ V _{PVINL}
SW to PGNDS			-0.3 V ~ 6.0 V
SFB / VLIM/SD / ILIM /CONT/ EN/SY to AGND			-0.3 V ~ V _{VDD}
AGND to PGNDL / PGNDS			-0.3 V ~ 0.3 V
VDD / ITEC / VTEC to AGND			-0.3 V ~ 6.0 V
VREF to AGND			-0.3 V ~ 3 V
Maximum Current			
VREF to AGND			20 mA
ITEC to AGND			50 mA
VTEC to AGND			50 mA
Maximum junction temperature, TJMAX			150°C
Storage temperature range, TSTG			-65°~+150°C
Operating temperature range, TJ			-40°C~+125°C
Package Thermal Resistance	Junction to Ambient, Rth-JA	WLCSP	48 °C/W
		QFN	37 °C/W
	Junction to Case, Rth-JC	WLCSP	0.6 °C/W
		QFN	1.65 °C/W
ESD (HBM)			2000 V
ESD (MM)			200 V
ESD (FICDM)			1500 V
Latch-up			+/- 100 mA

Note: Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

Test condition is $V_{IN} = 2.7\text{ V to }5.5\text{ V}$, $T_J = -40^{\circ}\text{C} \sim +125^{\circ}\text{C}$ for minimum/maximum specifications, and $T_A = 25^{\circ}\text{C}$ for typical specifications, unless otherwise specified.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Power Supply						
V_{PVIN}	Driver Supply Voltage		2.7		5.5	V
V_{VDD}	Controller Supply Voltage		2.7		5.5	V
I_{VDD}	Supply Current	PWM switching		12		mA
I_{SD}	Shutdown Current	EN/SY = AGND or VLIM/SD = AGND		350	700	μA
UVLO	Under Voltage Lockout Threshold	V_{VDD} Rising	2.45	2.55	2.65	V
	Under Voltage Lockout Hysteresis		80	90	100	mV
Reference Voltage						
V_{VREF}	Reference Voltage	$I_{VREF} = 0\text{ mA to }10\text{ mA}$	2.475	2.50	2.525	V
Linear Output						
V_{LDR}	Output Voltage Low	$I_{LDR} = 0\text{ A}$		0		V
	Output Voltage High			V_{PVIN}		
I_{LDR_SOURCE}	Maximum Source Current	$T_J = -40^{\circ}\text{C to }+105^{\circ}\text{C}$	1.5			A
		$T_J = -40^{\circ}\text{C to }+125^{\circ}\text{C}$	1.2			
I_{LDR_SINK}	Maximum Sink Current	$T_J = -40^{\circ}\text{C to }+105^{\circ}\text{C}$			1.5	A
		$T_J = -40^{\circ}\text{C to }+125^{\circ}\text{C}$			1.2	
$R_{DS(on)_PMOS}$	P-MOSFET ON Resistance ($I_{LDR} = 0.6\text{ A}$)	WLCSP, $V_{PVIN} = 5.0\text{ V}$		28	35	m Ω
		WLCSP, $V_{PVIN} = 3.3\text{ V}$		31	38	
		QFN, $V_{PVIN} = 5.0\text{ V}$		50	65	
		QFN, $V_{PVIN} = 3.3\text{ V}$		53	70	
$R_{DS(on)_NMOS}$	N-MOSFET ON Resistance ($I_{LDR} = 0.6\text{ A}$)	WLCSP, $V_{PVIN} = 5.0\text{ V}$		21	30	m Ω
		WLCSP, $V_{PVIN} = 3.3\text{ V}$		23	35	
		QFN, $V_{PVIN} = 5.0\text{ V}$		37	55	
		QFN, $V_{PVIN} = 3.3\text{ V}$		40	65	
$I_{LDR_P_LKG}$	P-MOSFET Leakage Current			0.1	10	μA
$I_{LDR_N_LKG}$	N-MOSFET Leakage Current			0.1	10	μA
ALDR	Linear Amplifier Gain			40		V/V
$I_{LDR_SH_GNDL}$	LDR Short-Circuit Threshold	LDR short to PGNDL, enter hiccup		2.2		A
$I_{LDR_SH_PVIN(L)}$	LDR Short-Circuit Threshold	LDR short to PVIN, enter hiccup		-2.2		A

T_{HICUP}	Hiccup Cycle			15		ms
PWM Output						
V_{SFB}	Output Voltage Low	$I_{SFB} = 0\text{ A}$		$0.06 \times V_{PVIN}$		V
	Output Voltage High			$0.93 \times V_{PVIN}$		
I_{SW_SOURCE}	Maximum Source Current	$T_J = -40^{\circ}\text{C to } +105^{\circ}\text{C}$	1.5			A
		$T_J = -40^{\circ}\text{C to } +125^{\circ}\text{C}$	1.2			
I_{SW_SINK}	Maximum Sink Current	$T_J = -40^{\circ}\text{C to } +105^{\circ}\text{C}$			1.5	A
		$T_J = -40^{\circ}\text{C to } +125^{\circ}\text{C}$			1.2	
$R_{DS(on)_PMOS}$	P-MOSFET ON Resistance ($I_{LDR} = 0.6\text{ A}$)	WLCSP, $V_{PVIN} = 5.0\text{ V}$		47	65	mΩ
		WLCSP, $V_{PVIN} = 3.3\text{ V}$		60	80	
		QFN, $V_{PVIN} = 5.0\text{ V}$		60	80	
		QFN, $V_{PVIN} = 3.3\text{ V}$		70	95	
$R_{DS(on)_NMOS}$	N-MOSFET ON Resistance ($I_{LDR} = 0.6\text{ A}$)	WLCSP, $V_{PVIN} = 5.0\text{ V}$		40	60	mΩ
		WLCSP, $V_{PVIN} = 3.3\text{ V}$		45	65	
		QFN, $V_{PVIN} = 5.0\text{ V}$		45	75	
		QFN, $V_{PVIN} = 3.3\text{ V}$		55	85	
$I_{LDR_P_LKG}$	P-MOSFET Leakage Current			0.1	10	μA
$I_{LDR_N_LKG}$	N-MOSFET Leakage Current			0.1	10	μA
t_{SW_R}	SW Node Rise Time	$C_{SW} = 1\text{ nF}$		1		ns
D_{SW}	PWM Duty Cycle		6		93	%
I_{SFB}	SFB Input Bias Current			1	2	μA
PWM Oscillator						
f_{OSC}	Internal Oscillator Frequency	EN/SY high	1.85	2.0	2.15	MHz
V_{EN/SY_ILOW}	EN/SY Input Voltage Low				0.8	V
V_{EN/SY_IHIGH}	EN/SY Input Voltage High		2.1			V
f_{SYNC}	External Synchronization Frequency		1.85		3.25	MHz
D_{SYNC}	Synchronization Pulse Duty Cycle		10		90	%
t_{SYNC_PWM}	EN/SY Rising to PWM Rising Delay			50		ns
t_{SY_LOCK}	EN/SY to PWM Lock Time	Number of SYNC cycles			10	Cycles
$I_{EN/SY}$	EN/SY Input Current			0.3	0.5	μA
$I_{PULL-DOWN}$	Pull-Down Current			0.3	0.5	μA
TEC Current Limit						
V_{ILIMC}	ILIM Input Voltage Range Cooling		1.3		$V_{VREF} - 0.2$	V

V _{ILIMH}	ILIM Input Voltage Range Heating		0.2		1.2	V
V _{ILIMC_TH}	Current-Limit Threshold Cooling	V _{ITEC} = 0.5 V	1.98	2.0	2.02	V
V _{ILIMH_TH}	Current-Limit Threshold Heating	V _{ITEC} = 2 V	0.48	0.5	0.52	V
I _{ILIMH}	ILIM Input Current Heating		-0.2		+0.2	μA
I _{ILIMC}	ILIM Input Current Cooling	Sourcing current	37.5	40	42.5	μA
I _{COOL_HEAT_TH}	Cooling to Heating Current Detection Threshold			40		mA
TEC Voltage Limit						
A _{VLIM}	Voltage Limit Gain	(V _{DRL} - V _{SFB})/V _{VLIM}		2		V/V
V _{VLIM}	VLIM/SD Input Voltage Range		0.2		V _{VDD} /2	V
I _{ILIMC}	VLIM/SD Input Current Cooling	V _{OUT2} < V _{VREF} /2	-0.2		+0.2	μA
I _{ILIMH}	VLIM/SD Input Current Heating	V _{OUT2} > V _{VREF} /2, sinking current	8	10	12	μA
TEC Current Measurement (WLCSP)						
R _{CS}	Current Sense Gain	V _{PVIN} = 3.3 V		0.525		V/A
		V _{PVIN} = 5 V		0.525		V/A
I _{ILDR_ERROR}	Current Measurement Accuracy	700mA ≤ I _{LDR} ≤ 1 A, V _{PVIN} = 3.3 V	-10		+10	%
		800mA ≤ I _{LDR} ≤ 1 A, V _{PVIN} = 5 V	-10		+10	%
V _{ITEC_@_700mA}	ITEC Voltage Accuracy	V _{PVIN} = 3.3 V, cooling, V _{VREF} /2 + I _{LDR} × R _{CS}	1.597	1.618	1.649	V
V _{ITEC_@_-700mA}		V _{PVIN} = 3.3 V, heating, V _{VREF} /2 - I _{LDR} × R _{CS}	0.846	0.883	0.891	V
V _{ITEC_@_800mA}		V _{PVIN} = 5 V, cooling, V _{VREF} /2 + I _{LDR} × R _{CS}	1.657	1.678	1.718	V
V _{ITEC_@_-800mA}		V _{PVIN} = 5 V, heating, V _{VREF} /2 - I _{LDR} × R _{CS}	0.783	0.822	0.836	V
TEC Current Measurement (QFN)						
R _{CS}	Current Sense Gain	V _{PVIN} = 3.3 V		0.525		V/A
		V _{PVIN} = 5 V		0.525		V/A
I _{ILDR_ERROR}	Current Measurement Accuracy	700mA ≤ I _{LDR} ≤ 1 A, V _{PVIN} = 3.3 V	-15		+15	%
		800mA ≤ I _{LDR} ≤ 1 A, V _{PVIN} = 5 V	-15		+15	%
V _{ITEC_@_700mA}	ITEC Voltage Accuracy	V _{PVIN} = 3.3 V, cooling, V _{VREF} /2 + I _{LDR} × R _{CS}	1.374	1.618	1.861	V
V _{ITEC_@_-700mA}		V _{PVIN} = 3.3 V, heating, V _{VREF} /2 - I _{LDR} × R _{CS}	0.750	0.883	1.015	V
V _{ITEC_@_800mA}		V _{PVIN} = 5 V, cooling, V _{VREF} /2 + I _{LDR} × R _{CS}	1.419	1.678	1.921	V

$V_{ITEC_@}$ -800mA		$V_{PVIN} = 5\text{ V, heating, } V_{VREF}/2 - I_{LDR} \times R_{CS}$	0.705	0.830	0.955	V
V_{ITEC}	ITEC Voltage Output Range	$I_{TEC} = 0\text{ A}$	0		$V_{VREF} - 0.05$	V
V_{ITEC_BIAS}	ITEC Bias Voltage	$I_{LDR} = 0\text{ A}$	1.215	1.250	1.285	V
I_{ITEC_Max}	Maximum ITEC Output Current		-2		+2	mA
TEC Voltage Measurement						
A_{VTEC}	Voltage Sense Gain		0.24	0.25	0.26	V/V
$V_{VTEC_@_1_V}$	Voltage Measurement Accuracy	$V_{LDR} - V_{SFB} = 1\text{ V, } V_{VREF}/2 + A_{VTEC} \times (V_{LDR} - V_{SFB})$	1.475	1.500	1.525	V
V_{VTEC}	VTEC Output Voltage Range		0.005		2.625	V
V_{VTEC_B}	VTEC Bias Voltage	$V_{LDR} = V_{SFB}$	1.225	1.250	1.275	V
I_{VTEC_Max}	Maximum VTEC Output Current		-2		+2	mA
Internal Soft Start						
t_{ss}	Soft Start Time			80		ms
VLIM/SD SHUTDOWN						
V_{VLIM/SD_THL}	VLIM/SD Low Voltage Threshold				0.07	V
Thermal SHUTDOWN						
T_{SHDN_TH}	Thermal Shutdown Threshold			170		°C
T_{SHDN_HYS}	Thermal Shutdown Hysteresis			17		°C

TYPICAL OPERATING CHARACTERISTICS

$T_A = 25^\circ\text{C}$, unless otherwise specified.

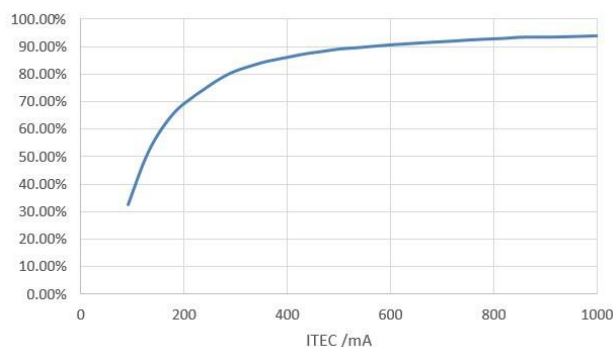


Figure 4. Efficiency vs. ITEC at $V_{IN}=3.3\text{V}$ in Cooling Mode

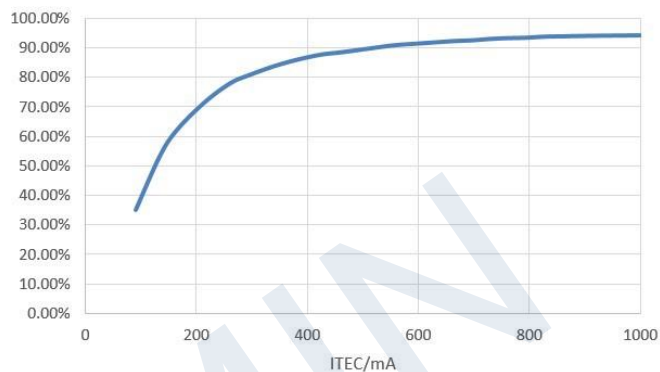


Figure 5. Efficiency vs. ITEC at $V_{IN}=3.3\text{V}$ in Heating Mode

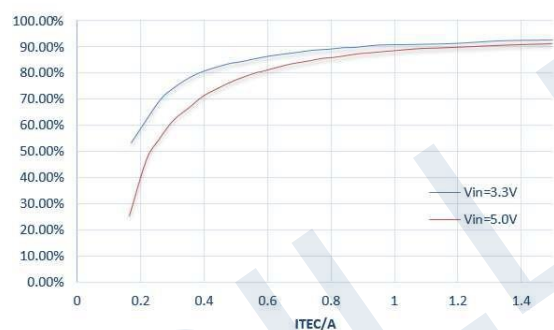


Figure 6. Efficiency vs. ITEC at $V_{IN}=3.3\text{V}$ and 5.0V with 2Ω Load in Cooling Mode

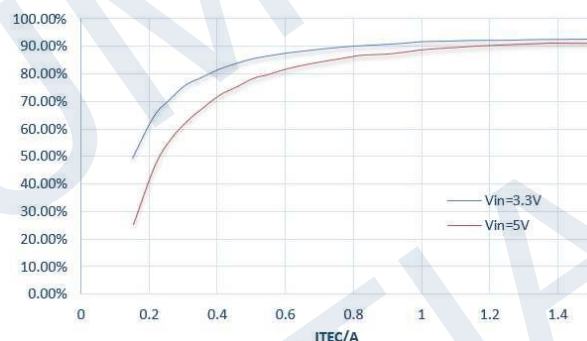


Figure 7. Efficiency vs. ITEC at $V_{IN}=3.3\text{V}$ and 5.0V with 2Ω Load in Heating Mode

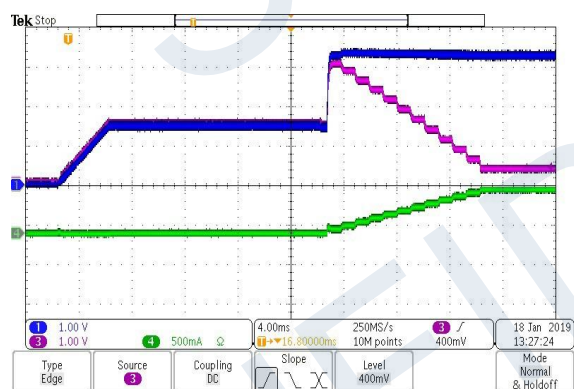


Figure 8. Soft Start into Cooling Mode ($V_{IN}=3.3\text{V}$ with 5Ω load)

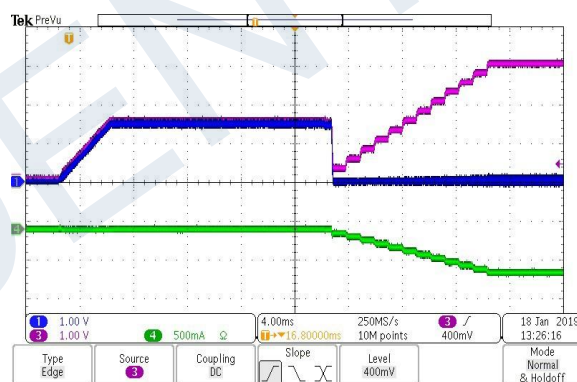


Figure 9. Soft Start into Heating Mode ($V_{IN}=3.3\text{V}$ with 5Ω load)

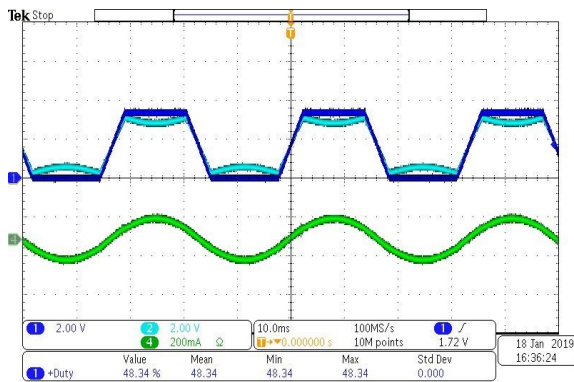


Figure 10. Cooling to Heating Transient
(Line 1: LDR (TEC+), Line 2: SFB (TEC-), Line 4: ITEC)

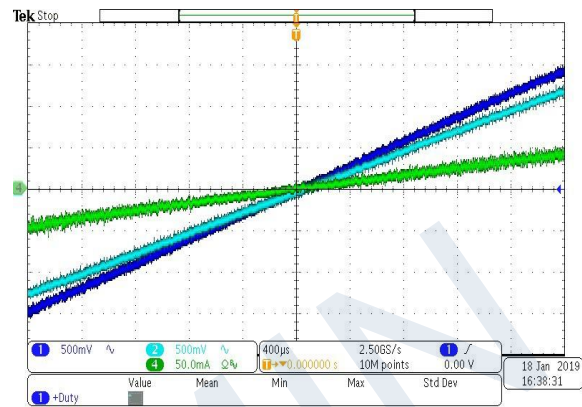


Figure 11. Zero Crossing TEC Current Zoom-in from Heating to Cooling
(Line 1: LDR (TEC+), Line 2: SFB (TEC-), Line 4: ITEC)

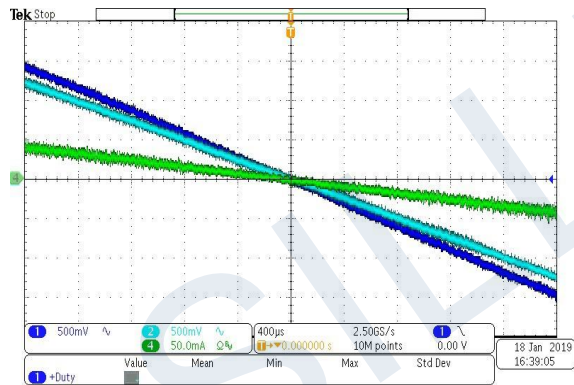


Figure 12. Zero Crossing TEC Current Zoom-in from Cooling to Heating
(Line 1: LDR (TEC+), Line 2: SFB (TEC-), Line 4: ITEC)

APPLICATION INFORMATION

The SLM8833 is a single chip TEC controller that sets and stabilizes a TEC temperature. A control voltage from a DAC applied to the CONT input pin of the SLM8833 corresponds to the temperature setpoint of the target object attached to the TEC. The SLM8833 controls an internal FET H-bridge whereby the direction of the current fed through the TEC can be either positive (for cooling mode), to pump heat away from the object attached to the TEC, or negative (for heating mode), to pump heat into the object attached to the TEC. Temperature is measured with a thermal sensor attached to the target object and the sensed temperature (voltage) is fed back to an ADC to complete a closed digital thermal control loop of the TEC. For the best overall stability, couple the thermal sensor close to the TEC. In most laser diode modules, a TEC and a NTC thermistor are already mounted in the same package to regulate the laser diode temperature.

The TEC is differentially driven in an H-bridge configuration. The SLM8833 drives its internal MOSFET transistors to provide the TEC current. To provide good power efficiency and zero crossing quality, only one side of the H-bridge uses a PWM driver. Only one inductor and one capacitor are required to filter out the switching frequency. The other side of the H-bridge uses a linear output without requiring any additional circuitry. This proprietary configuration allows the SLM8833 to provide efficiency of >90%. For most applications, a 1 μ H inductor, a 10 μ F capacitor, and a switching frequency of 2 MHz maintain less than 1% of the worst-case output voltage ripple across a TEC.

The maximum voltage across the TEC and the current flowing through the TEC are set by using the VLIM/SD and ILIM pins. The maximum cooling and heating currents can be set independently to allow asymmetric heating and cooling limits. For additional details, see the Maximum TEC Voltage Limit section and the Maximum TEC Current Limit section.

DIGITAL PID CONTROL

The SLM8833 is used in a software controlled PID loop. An amplifier conditions the signal from the thermistor and connects to an external temperature measurement ADC. The signal from an external DAC that controls the temperature setpoint is applied to the CONT input pin.

POWERING THE CONTROLLER

The SLM8833 operates at an input voltage range of 2.7 V to 5.5 V that is applied to the VDD pin and the PVIN pin for the WLCSP (the PVINS pin and PVINL pin for the LFCSP). The VDD pin is the input power for

the driver and internal reference. The PVIN input power pins are combined for both the linear and the switching driver. Apply the same input voltage to all power input pins: VDD and PVIN. In some circumstances, an RC lowpass filter can be added optionally between the PVIN for the WLCSP (PVINS and PVINL for the LFCSP) and VDD pins to prevent high frequency noise from entering VDD, as shown in Figure 3. The capacitor and resistor values are typically 10 Ω and 100 nF, respectively. When configuring power supply to the SLM8833, keep in mind that at high current loads, the input voltage may drop substantially due to a voltage drop on the wires between the front-end power supply and the PVIN for the WLCSP (PVINS and PVINL for the LFCSP) pin. Leave a proper voltage margin when designing the front-end power supply to maintain the performance. Minimize the trace length from the power supply to the PVIN for the WLCSP (PVINS and PVINL for the LFCSP) pin to help mitigate the voltage drop. The features internal automatic over-voltage protection, when output voltage is higher than 115%.

ENABLE AND SHUTDOWN

To enable the SLM8833, apply a logic high voltage to the EN/SY pin while the voltage at the VLIM/SD pin is above the maximum shutdown threshold of 0.07 V. If either the EN/SY pin voltage is set to logic low or the VLIM/SD voltage is below 0.07 V, the controller goes into an ultralow current state. The current drawn in shutdown mode is 350 μ A typically. Most of the current is consumed by the VREF circuit block, which is always on even when the device is disabled or shut down. The device can also be enabled when an external synchronization clock signal is applied to the EN/SY pin, and the voltage at VLIM/SD input is above 0.07 V. Table 6 shows the combinations of the two input signals that are required to enable the SLM8833.

EN/SY Input	VLIM/SD Input	Controller
>2.1 V	>0.07 V	Enabled
Switching between high >2.1 V and low < 0.8 V	>0.07 V	Enabled
<0.8 V	No effect ¹	Shutdown
Floating	No effect ¹	Shutdown
No effect ¹	$\leq$ 0.07 V	Shutdown

¹ No effect means this signal has no effect in shutting down or in enabling the device.

OSCILLATOR CLOCK FREQUENCY

The SLM8833 has an internal oscillator that generates a 2.0 MHz switching frequency for the PWM output stage. This oscillator is active when the enabled voltage at the EN/SY pin is set to a logic level higher than 2.1 V and the VLIM/SD pin voltage is greater than the shutdown threshold of 0.07 V.

External Clock Operation

The PWM switching frequency of the SLM883 can be synchronized to an external clock from 1.85 MHz to 3.25 MHz, applied to the EN/SY input pin as shown on Figure 13.

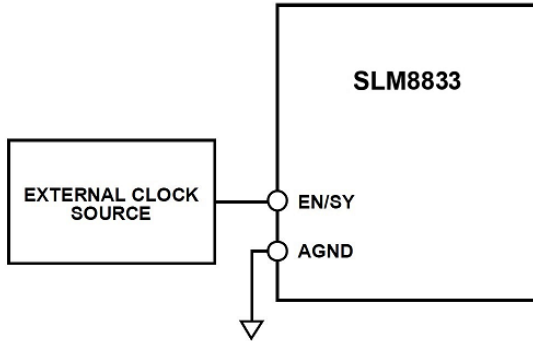


Figure 13. Synchronize to an External Clock

Connecting Multiple SLM8833 Devices

Multiple SLM883 devices can be driven from a single master clock signal by connecting the external clock source to the EN/SY pin of each slave device. The input ripple can be greatly reduced by operating the SLM8833 devices 180° out of phase from each other by placing an inverter at one of the EN/SY pins as shown in Figure 14.

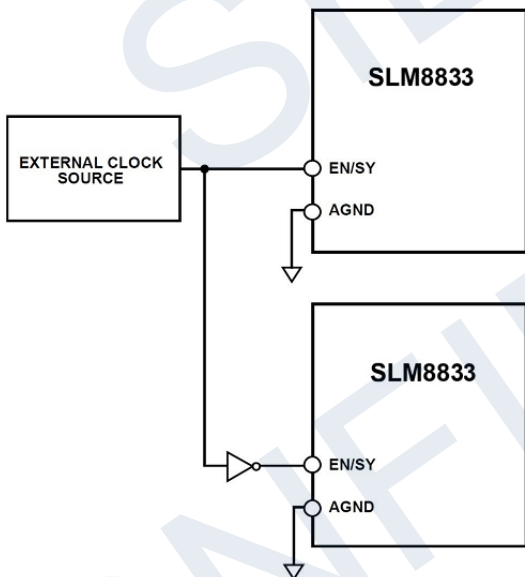


Figure 14. Multiple SLM8833 Devices Driven from a Master Clock

SOFT START ON POWER-UP

The SLM8833 has an internal soft start circuit that generates a ramp with a typical 150 ms profile to minimize inrush current during power-up. The settling time and the final voltage across the TEC depends on the TEC voltage required by the control voltage of voltage loop. The higher the TEC voltage is, the

longer it requires to be built up.

When the SLM8833 is first powered up, the linear side discharges the output of any prebias voltage. As soon as the prebias is eliminated, the soft start cycle begins. During the soft start cycle, both the PWM and linear outputs track the internal soft start ramp until they reach midscale, where the control voltage, V_C , is equal to the bias voltage, V_B . From the midscale voltage, the PWM and linear outputs are then controlled by V_C and diverge from each other until the required differential voltage is developed across the TEC or the differential voltage reaches the voltage limit. The voltage developed across the TEC depends on the control point at that moment in time. Figure 15 shows an example of the soft start in cooling mode. Note that, as both the LDR and SFB voltages increase with the soft start ramp and approach V_B , the ramp slows down to avoid possible current overshoot at the point where the TEC voltage starts to build up.

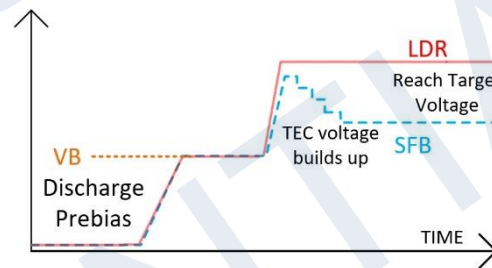


Figure 15. Soft Start Profile in Cooling Mode

TEC VOLTAGE/CURRENT MONITOR

The TEC real-time voltage and current are detectable at VTEC and ITEC, respectively.

Voltage Monitor

VTEC is an analog voltage output pin with a voltage proportional to the actual voltage across the TEC. A center VTEC voltage of 1.25 V corresponds to 0 V across the TEC. Convert the voltage at VTEC and the voltage across the TEC using the following equation:

$$V_{VTEC} = 1.25 \text{ V} + 0.25 \times (V_{LDR} - V_{SFB})$$

Current Monitor

ITEC is an analog voltage output pin with a voltage proportional to the actual current through the TEC. A center ITEC voltage of 1.25 V corresponds to 0 A through the TEC. Convert the voltage at ITEC and the current through the TEC using the following equations:

$$V_{ITEC_COOLING} = 1.25 \text{ V} + I_{LDR} \times R_{CS}$$

where the current sense gain (R_{CS}) is 0.525 V/A.

$$V_{ITEC_HEATING} = 1.25 \text{ V} - I_{LDR} \times R_{CS}$$

MAXIMUM TEC VOLTAGE LIMIT

The maximum TEC voltage is set by applying a voltage divider at the VLIM/SD pin to protect the TEC. The voltage limiter operates bidirectionally and allows the cooling limit to be different from the heating limit.

Using a Resistor Divider to Set the TEC Voltage Limit

Separate voltage limits are set using a resistor divider. The internal current sink circuitry connected to VLIM/SD draws a current when the SLM8833 drives the TEC in a heating direction, which lowers the voltage at VLIM/SD. The current sink is not active when the TEC is driven in a cooling direction; therefore, the TEC heating voltage limit is always lower than the cooling voltage limit.

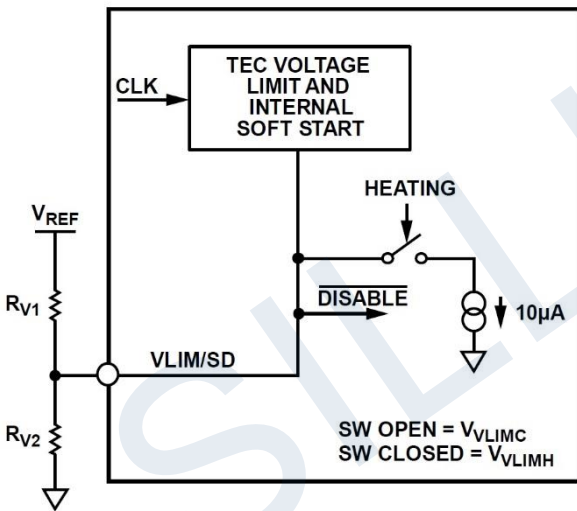


Figure 16. Using a Resistor Divider to Set the TEC Voltage Limit

Calculate the cooling and heating limits using the following equations:

$$V_{VLIM_COOLING} = V_{REF} \times R_{V2} / (R_{V1} + R_{V2})$$

where $V_{REF} = 2.5 \text{ V}$.

$$V_{VLIM_HEATING} = V_{VLIM_COOLING} - I_{SINK_VLIM} \times R_{V1} || R_{V2}$$

where $I_{SINK_VLIM} = 10 \mu\text{A}$.

$$V_{TEC_MAX_COOLING} = V_{VLIM_COOLING} \times A_{VLIM}$$

where $A_{VLIM} = 2 \text{ V/V}$.

$$V_{TEC_MAX_HEATING} = V_{VLIM_HEATING} \times A_{VLIM}$$

MAXIMUM TEC CURRENT LIMIT

To protect the TEC, separate maximum TEC current limits in cooling and heating directions are set by applying a voltage combination at the ILIM pin.

Using a Resistor Divider to Set the TEC Current Limit

The internal current sink circuitry connected to ILIM draws a $40 \mu\text{A}$ current when the SLM8833 drives the TEC in a cooling direction, which allows a high cooling current. Use the following equations to calculate the maximum TEC currents:

$$V_{ILIM_HEATING} = V_{REF} \times R_{C2} / (R_{C1} + R_{C2})$$

where $V_{REF} = 2.5 \text{ V}$.

$$V_{ILIM_COOLING} = V_{ILIM_HEATING} + I_{SINK_ILIM} \times R_{C1} || R_{C2}$$

where $I_{SINK_ILIM} = 40 \mu\text{A}$.

$$I_{TEC_MAX_COOLING} = \frac{V_{ILIM_COOLING} - 1.25 \text{ V}}{R_{CS}}$$

where $R_{CS} = 0.525 \text{ V/A}$.

$$I_{TEC_MAX_HEATING} = \frac{1.25 \text{ V} - V_{ILIM_HEATING}}{R_{CS}}$$

$V_{ILIM_HEATING}$ must not exceed 1.2 V and $V_{ILIM_COOLING}$ must be more than 1.3 V to leave proper margins between the heating and the cooling modes.

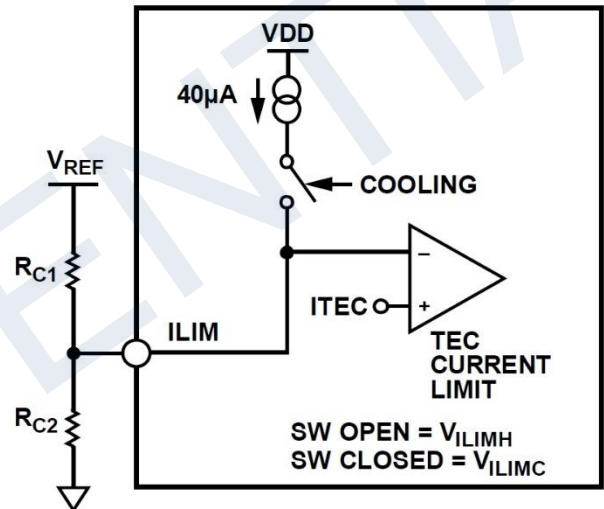


Figure 17. Using a Resistor Divider to Set the TEC Current Limit

CLASSIFICATION REFLOW PROFILES

Profile Feature	Pb-Free Assembly
Preheat & Soak	150°C
Temperature min (T _{smin})	200°C
Temperature max (T _{smax})	60-120 seconds
Time (T _{smin} to T _{smax}) (t _s)	
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.
Liquidous temperature (T _L)	217°C
Time at liquidous (t _L)	60-150 seconds
Peak package body temperature (T _p)*	Max 260°C
Time (t _p)** within 5°C of the specified classification temperature (T _c)	Max 30 seconds
Average ramp-down rate (T _p to T _{smax})	6°C/second max.
Time 25°C to peak temperature	8 minutes max.

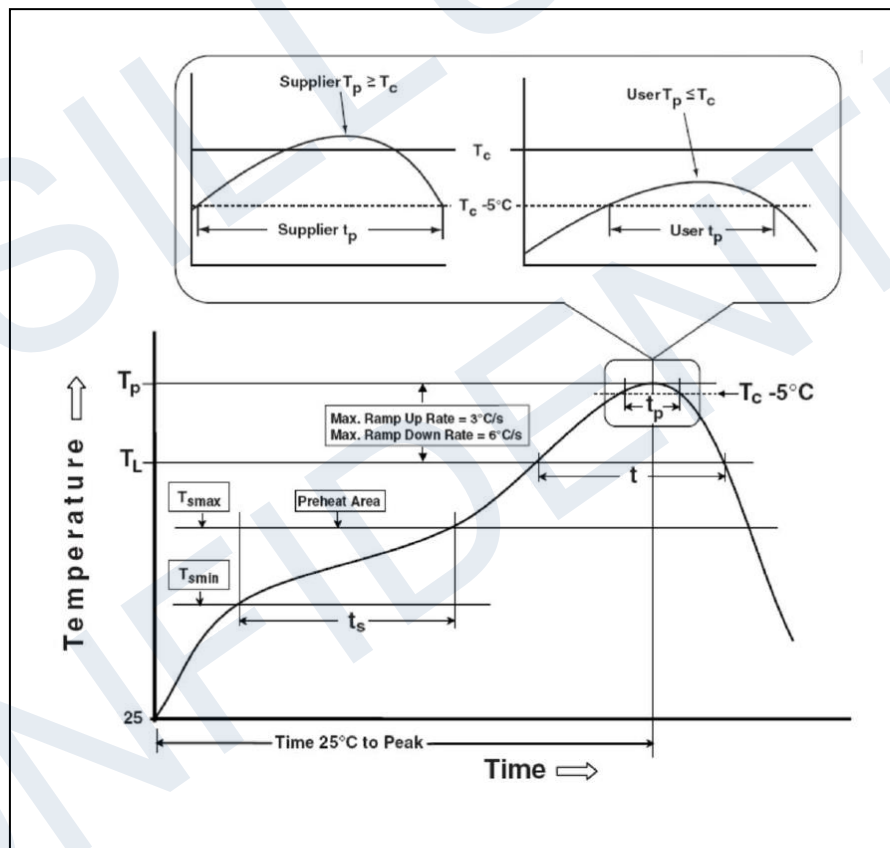


Figure 18. Classification Profile

PACKAGE CASE OUTLINES

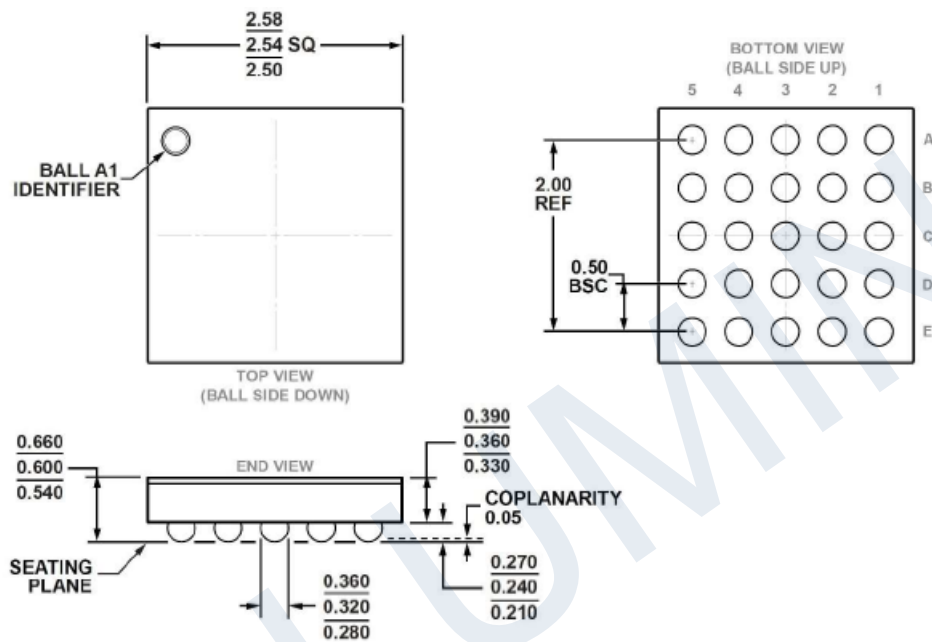


Figure 19. 25 ball, 2.5mm x 2.5mm WLCSP Outline Dimensions

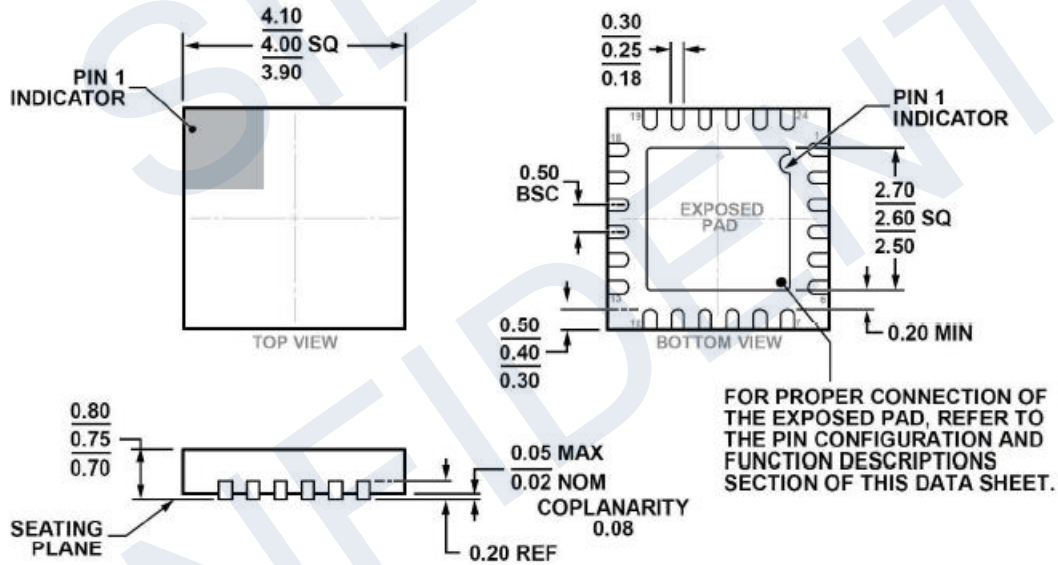


Figure 20. 24 Lead, 4mm x 4mm QFN Outline Dimensions

REVISION HISTORY

Note: page numbers for previous revisions may differ from page numbers in current version

Page or Item	Subjects (major changes since previous revision)
Rev 0.2 datasheet, 2019-9-3	
Whole document	New company logo released
Page 1	Remove "Rev0.1 January 2019"
Rev 1.0 datasheet, 2022-7-20	
Whole datasheet	Update the format